

# INTERNATIONAL STANDARD

## NORME INTERNATIONALE



**Optical amplifiers – Test methods –  
Part 4-1: Gain transient parameters – Two-wavelength method**

**Amplificateurs optiques – Méthodes d'essai –  
Partie 4-1: Paramètres de gain transitoire – Méthode à deux longueurs d'onde**

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## CONTENTS

FOREWORD.....	3
INTRODUCTION.....	5
1 Scope and object.....	6
2 Normative references.....	6
3 Terms, definitions and abbreviations.....	6
3.1 General.....	6
3.2 Terms and definitions.....	9
3.3 Abbreviated terms.....	10
4 Apparatus.....	11
5 Test specimen.....	11
6 Procedure.....	11
7 Calculations.....	12
8 Test results.....	12
Annex A (informative) Background on transient phenomenon in optical amplifiers.....	13
Annex B (informative) Slew rate effect on transient gain response.....	16
Bibliography.....	19
Figure 1 – Definitions of rise and fall times (a) in the case of a channel addition event, and (b) in the case of a channel removal event.....	7
Figure 2 – OFA transient gain response for (a) a channel removal event, and (b) a channel addition event.....	8
Figure 3 – Generic transient control measurement setup.....	11
Figure A.1 – EDFA pump control for a chain of 5 EDFAs and 4 fibre spans.....	14
Figure A.2 – EDFA spectral hole depth for different gain compression.....	15
Figure A.3 – EDFA spectral hole depth for different wavelengths.....	15
Figure B.1 – Transient gain response at various slew rates.....	17
Figure B.2 – 16 dB add/drop (rise time = 10 µsec).....	18
Figure B.3 – 16 dB add/drop (rise time = 1 000 µsec).....	18
Table 1 – Examples of add and drop scenarios for transient control measurement.....	12
Table 2 – Typical results of transient control measurement.....	12
Table B.1 – Transient gain response for various rise time and fall time (16 dB add/drop).....	17

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**OPTICAL AMPLIFIERS –  
TEST METHODS –**
**Part 4-1: Gain transient parameters –  
Two-wavelength method**

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The text of this standard is based on the following documents:

CDV	Report on voting
86C/956/CDV	86C/1011/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 61290 series, published under the general title *Optical amplifiers – Test methods* can be found on the IEC website.

Future standards in this series will carry the new general title as cited above. Titles of existing standards in this series will be updated at the time of the next edition.

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## INTRODUCTION

This part of IEC 61290-4 is devoted to the subject of Optical Amplifiers (OAs). The technology of optical amplifiers is quite new and still emerging; hence amendments and new editions to this standard can be expected.

Each abbreviation introduced in this standard is explained in the text at least the first time it appears. However, for an easier understanding of the whole text, a list of all abbreviations used in this standard is given in 3.3.

Background information on the transient phenomenon in erbium-doped fibre amplifiers and the consequences on fibre optic systems is provided in Annex A and on slow rate effects in Annex B.

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## OPTICAL AMPLIFIERS – TEST METHODS –

### Part 4-1: Gain transient parameters – Two-wavelength method

#### 1 Scope and object

This part of IEC 61290-4 applies to erbium-doped fibre amplifiers (EDFAs) and optically amplified elementary sub-systems. It applies to OAs using active fibres (optical fibre amplifiers, OFAs), containing rare-earth dopants. These amplifiers are commercially available and widely deployed in service provider networks.

The object of this part of IEC 61290-4 is to provide the general background for EDFA transients and related parameters, and to describe a standard test method for accurate and reliable measurement of the following transient parameters:

- Channel addition/removal transient gain overshoot and transient net gain overshoot
- Channel addition/removal transient gain undershoot and transient net gain undershoot
- Channel addition/removal gain offset
- Channel addition/removal transient gain response time constant (settling time)

#### 2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61291-1, *Optical amplifiers – Part 1: Generic specification*

NOTE A list of informative references is given in the Bibliography.

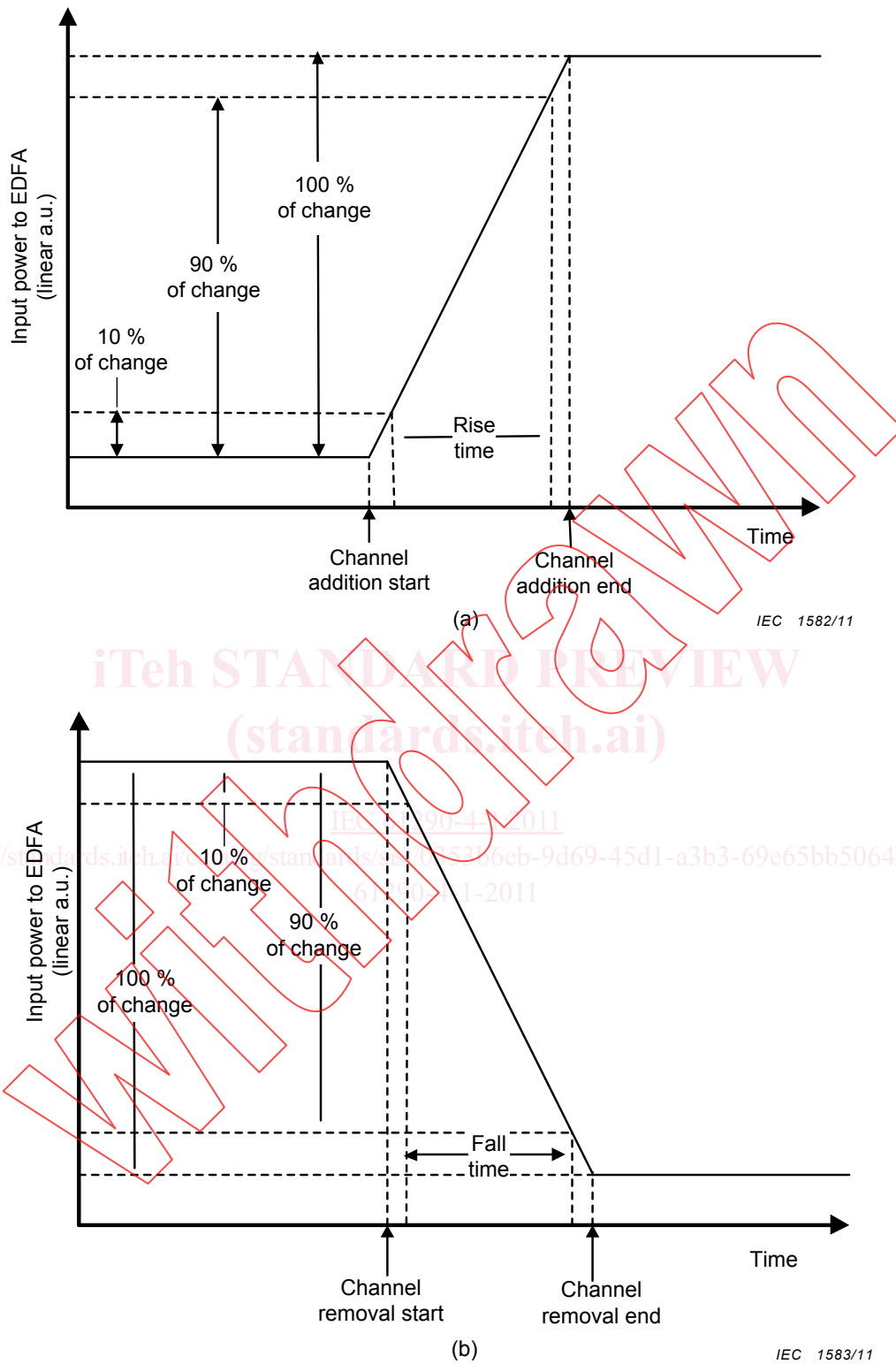
#### 3 Terms, definitions and abbreviations

##### 3.1 General

When the input power to an OFA operating in saturation changes sharply, the gain of the amplifier will typically exhibit a transient response before settling back into the required gain. This response is dictated both by the optical characteristics of the active fibre within the OFA as well as the performance of the automatic gain control (AGC) mechanism.

Since a change in input power typically occurs when part of the DWDM channels within the specified transmission band are dropped or added, definitions are provided that describe a dynamic event leading to transient response. Rise and fall time definitions are shown in Figure 1.





**Figure 1 – Definitions of rise and fall times (a) in the case of a channel addition event, and (b) in the case of a channel removal event**

The parameters generally used to characterize the transient gain behaviour of a gain controlled EDFA for the case of channel removal are defined in Figure 2(a). The figure specifically represents the time dependence of the gain of one of the surviving channels when channels

are removed. Likewise, the transient gain behaviour for the case when channels are added is shown in Figure 2(b). The main transient parameters are: transient gain response time constant (settling time), gain offset, transient net gain overshoot, and transient gain net undershoot. The transient gain overshoot and undershoot are particularly critical to carriers and network equipment manufacturers (NEMs) given that the speed and amplitude of gain fluctuations compound through the network as the optical signal passes through an increasing number of cascaded amplifiers. Properly designed optical amplifiers have very small values for these transient parameters.

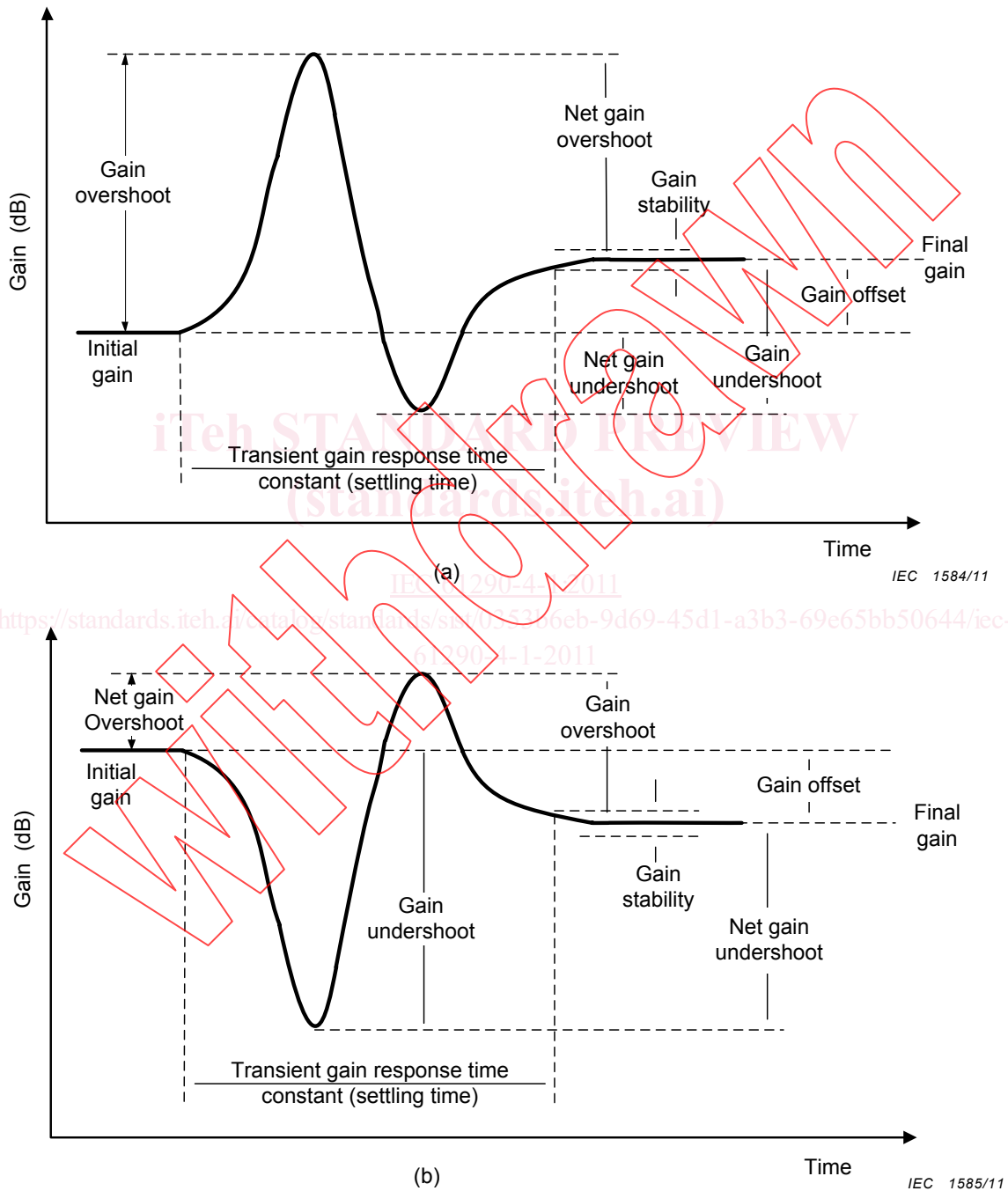


Figure 2 – OFA transient gain response for (a) a channel removal event, and (b) a channel addition event

## 3.2 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 61291-1 and the following apply.

### 3.2.1

#### **surviving (pre-existing) signal**

optical signal that remains (exists) after (before) drop (add) event

### 3.2.2

#### **saturating signal**

optical signal that is switched off (on) by the drop (add) event

### 3.2.3

#### **drop (add) level**

amount in dB by which the input power decreases (increases) due to dropping (adding) of channels

### 3.2.4

#### **add rise time**

time it takes for the input optical signal to rise from 10 % to 90 % of the total difference between the initial and final signal levels during an add event (see Figure 1(a))

### 3.2.5

#### **drop fall time**

time it takes for the input optical signal to fall from 10 % to 90 % of the total difference between the initial and final signal levels during a drop event (see Figure 1 (b))

### 3.2.6

#### **initial gain**

gain of the surviving (pre-existing) channel before a drop (add) event

### 3.2.7

#### **final gain**

steady state gain of the surviving (pre-existing) channel a very long time (i.e. once the gain has stabilized) after a drop (add) event

### 3.2.8

#### **gain offset**

Change in dB of the gain between initial and final state, defined as final gain – initial gain

NOTE Gain offset may be positive or negative for both channel addition and removal events

### 3.2.9

#### **gain stability**

specified peak-to-peak gain fluctuations of the OFA under steady state conditions (i.e. not in response to a transient event)

### 3.2.10

#### **transient gain response time constant (settling time)**

amount of time required to bring the gain of the surviving (pre-existing) channel to the final gain

NOTE 1 This parameter is the measured time from the beginning of the drop (add) event that created the transient gain response, to the time at which the surviving (pre-existing) channel gain first enters within the gain stability band centred on the final gain.

NOTE 2 Hereon this will also be referred to as settling time

### 3.2.11

#### **transient gain overshoot**

difference in dB between the maximum surviving (pre-existing) channel gain reached during the OFA transient response to a drop (add) event, and the lowest of either the initial gain and final gain

NOTE Hereon this will also be referred to as gain overshoot

### 3.2.12

#### **transient net gain overshoot**

difference in dB between the maximum surviving (pre-existing) channel gain reached during the OFA transient response to a drop (add) event, and the highest of either the initial gain and final gain. The transient net gain overshoot is just the transient gain overshoot minus the gain offset, and represents the actual transient response not related to the shift of the amplifier from the initial steady state condition to the final steady state condition

NOTE Hereon this will also be referred to as net gain overshoot

### 3.2.13

#### **transient gain undershoot**

difference in dB between the minimum surviving (pre-existing) channel gain reached during the OFA transient response to a drop (add) event, and the highest of either the initial gain and final gain

NOTE Hereon this will also be referred to as gain undershoot

### 3.2.14

#### **transient net gain undershoot**

difference in dB between the minimum surviving (pre-existing) channel gain reached during the OFA transient response to a drop (add) event and the lowest of either the initial gain and final gain.

NOTE 1 The transient net gain undershoot is just the transient gain undershoot minus the gain offset and represents the actual transient response not related to the shift of the amplifier from the initial steady state condition to the final steady state condition.

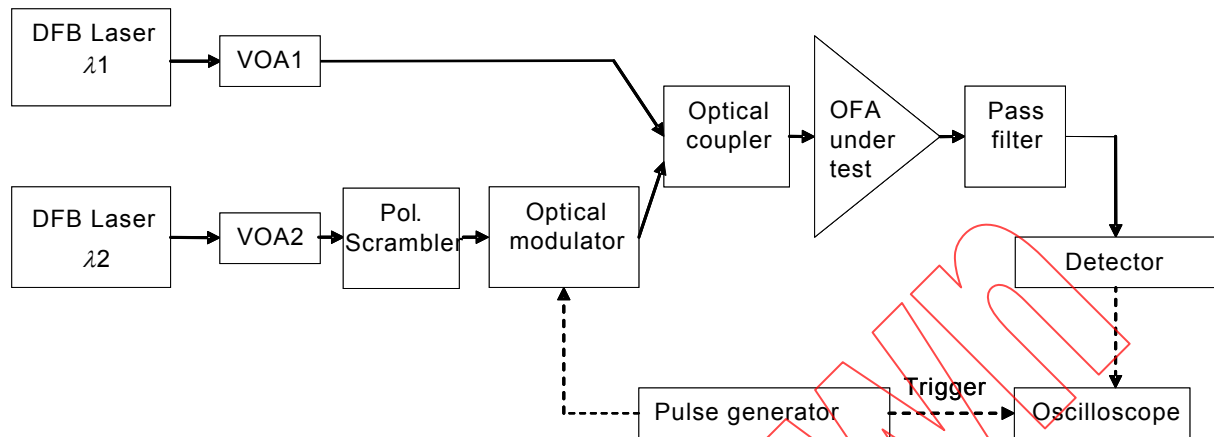
NOTE 2 Hereon this will also be referred to as net gain undershoot

## 3.3 Abbreviated terms

AGC	automatic gain control
AOM	acousto-optic modulator
BER	bit error ratio
DFB	distributed feedback
DWDM	dense wavelength division multiplexing
EDFA	erbium-doped fibre amplifier
FWHM	full width half maximum
NEM	network equipment manufacturer
NSP	network service provider
O/E	optical-to-electronic
OA	optical amplifier
OFA	optical fibre amplifier
OSNR	optical signal-to-noise ratio
SHB	spectral-hole-burning
VOA	variable optical attenuator
WDM	wavelength division multiplexing

## 4 Apparatus

Figure 3 shows a generic setup to characterize the transient response properties of OAs.



IEC 1693/11

Figure 3 – Generic transient control measurement setup

## 5 Test specimen

The OA shall operate at nominal operating conditions. If the OA is likely to cause laser oscillations due to unwanted reflections, optical isolators should be used to bracket the OA under test. This will minimize signal instability and measurement inaccuracy.

## 6 Procedure

In the setup shown, the input signal power into the amplifier being tested is the combination of two distributed feedback (DFB) lasers with wavelengths approximately 1 nm apart. Each channel is subsequently adjusted with a variable optical attenuator (VOA) to the desired optical input power levels. One optical modulator driven by a function generator acts as an on/off switch, to simulate add and drop events. The two optical channels are subsequently combined onto the same fibre before the signal is directed to the amplifier being tested. A tuneable filter, an optical-to-electronic (O/E) converter and an oscilloscope are placed in tandem at the output of the amplifier. The surviving channel is selected with the tuneable filter and its transient response is monitored with the O/E converter and oscilloscope. A waveform similar to the one shown in Figure 2 is displayed on the oscilloscope's screen.

To simulate a drop event at the input of the amplifier being tested, the two lasers are set so that their total input power is equal to the amplifier's typical input power (e.g. 1 dBm). Therefore, the two lasers at –2 dBm each represent 20 optical channels having –15 dBm power per channel. When the function generator turns the modulator into the “off” position, the second laser is completely suppressed, changing the system's channel loading. For instance, when one laser is switched off it simulates a 3 dB “drop” or a change in the system's channel loading from 40 channels to 20 channels. Similarly, when the modulator is changed into an “on” state, the addition of a second laser simulates a 3 dB add in optical power, or a change in the system's channel loading from 20 channels to 40 channels. For other transient control measurements, the VOAs can be adjusted accordingly so that the input power levels will differ by an appropriate value.

Several transient control measurements can be performed, according to the operating conditions and specifications that are provided. Measurements may also be taken for various add and drop scenarios as shown in Table 1. These measurements are typically performed over a broad range of input power levels.